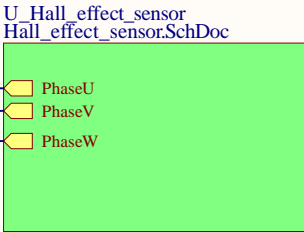
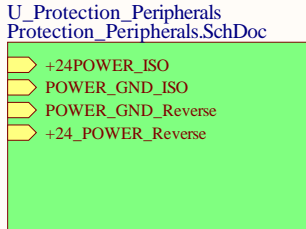
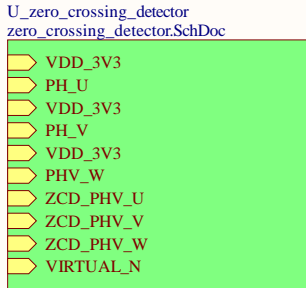
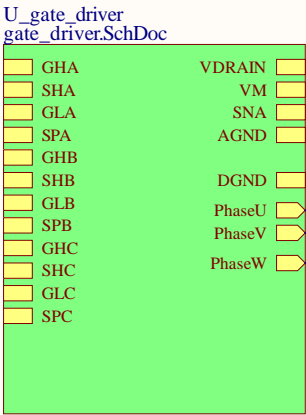
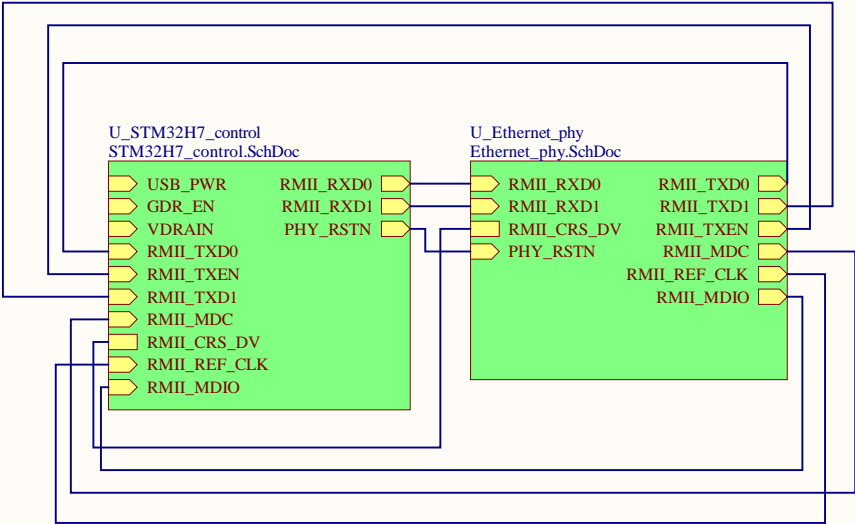
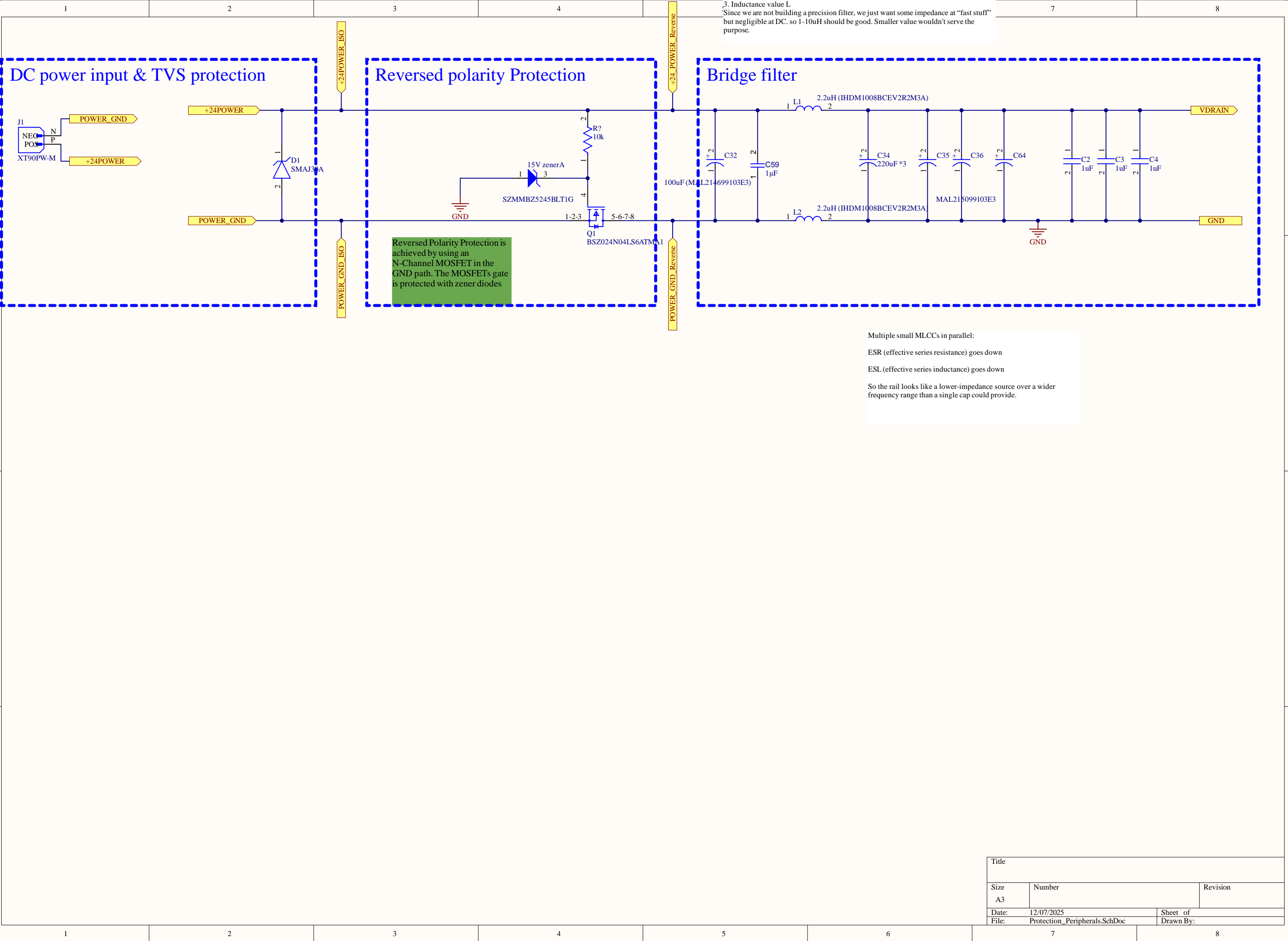
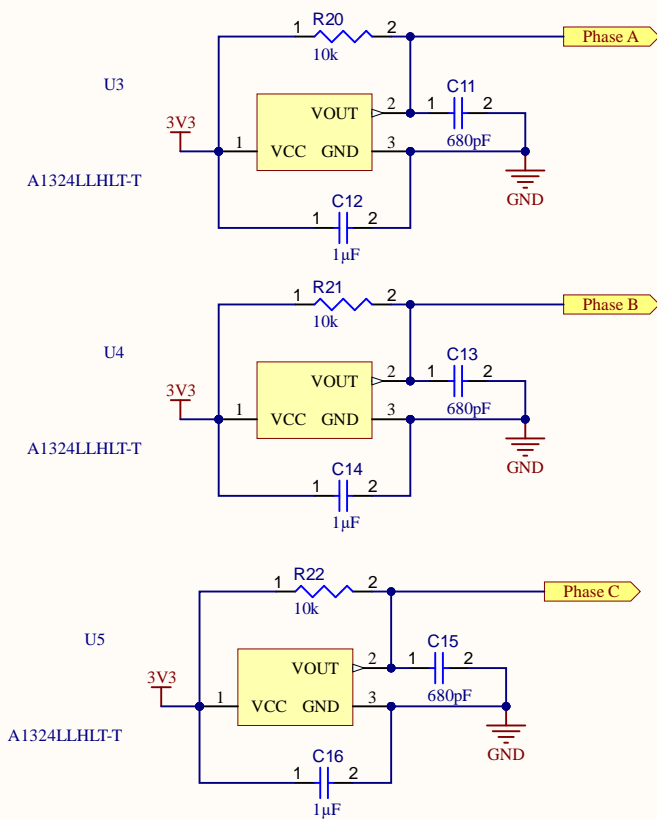


Chassis Grounding



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		A3		
SCALE:	FILE NAME	ESC_PCB_V2_Top_Level.SchDoc	SHEET	1 OF 11





Hall effect sensor implementation. Different chip symbol model used here and needs to be changed to TMAG5115 from Ti

Table 8-2. External Components

COMPONENT	PIN 1	PIN 2	RECOMMENDED
C1	V _{CC}	GND	A 0.01-µF (minimum) ceramic capacitor rated for V _{CC}
C2	OUT	GND	Optional: Place a ceramic capacitor to GND
R1	OUT	REF ⁽¹⁾	Requires a resistor pullup

(1) REF is not a pin on the TMAG5115 device, but a REF supply-voltage pullup is required for the OUT pin. The OUT pin may be pulled up to V_{CC}.

8.2.1.2.1 Configuration Example

In a 3.3-V system, $3.0V \leq V_{ref} \leq 3.6V$. Use Equation 2 to calculate the allowable range for R1.

$$\frac{V_{ref} \text{ max}}{30 \text{ mA}} \leq R1 \leq \frac{V_{ref} \text{ min}}{100 \mu A} \tag{2}$$

For this design example, use Equation 3 to calculate the allowable range of R1.

$$\frac{3.4 \text{ V}}{30 \text{ mA}} \leq R1 \leq \frac{3.2 \text{ V}}{100 \mu A} \tag{3}$$

Therefore:

$$120 \Omega \leq R1 \leq 30 \text{ k}\Omega \tag{4}$$

After finding the allowable range of R1 (Equation 4), select a value between 500 Ω and 32 kΩ for R1.

Assuming a system bandwidth of 10 kHz, use Equation 5 to calculate the value of C2.

$$2 \times f_{BW} \text{ (Hz)} < \frac{1}{2\pi \times R1 \times C2} \tag{5}$$

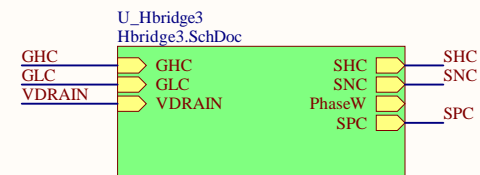
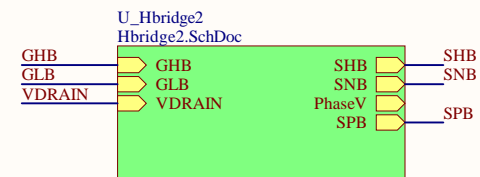
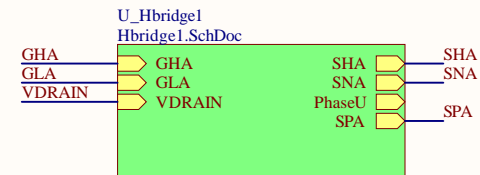
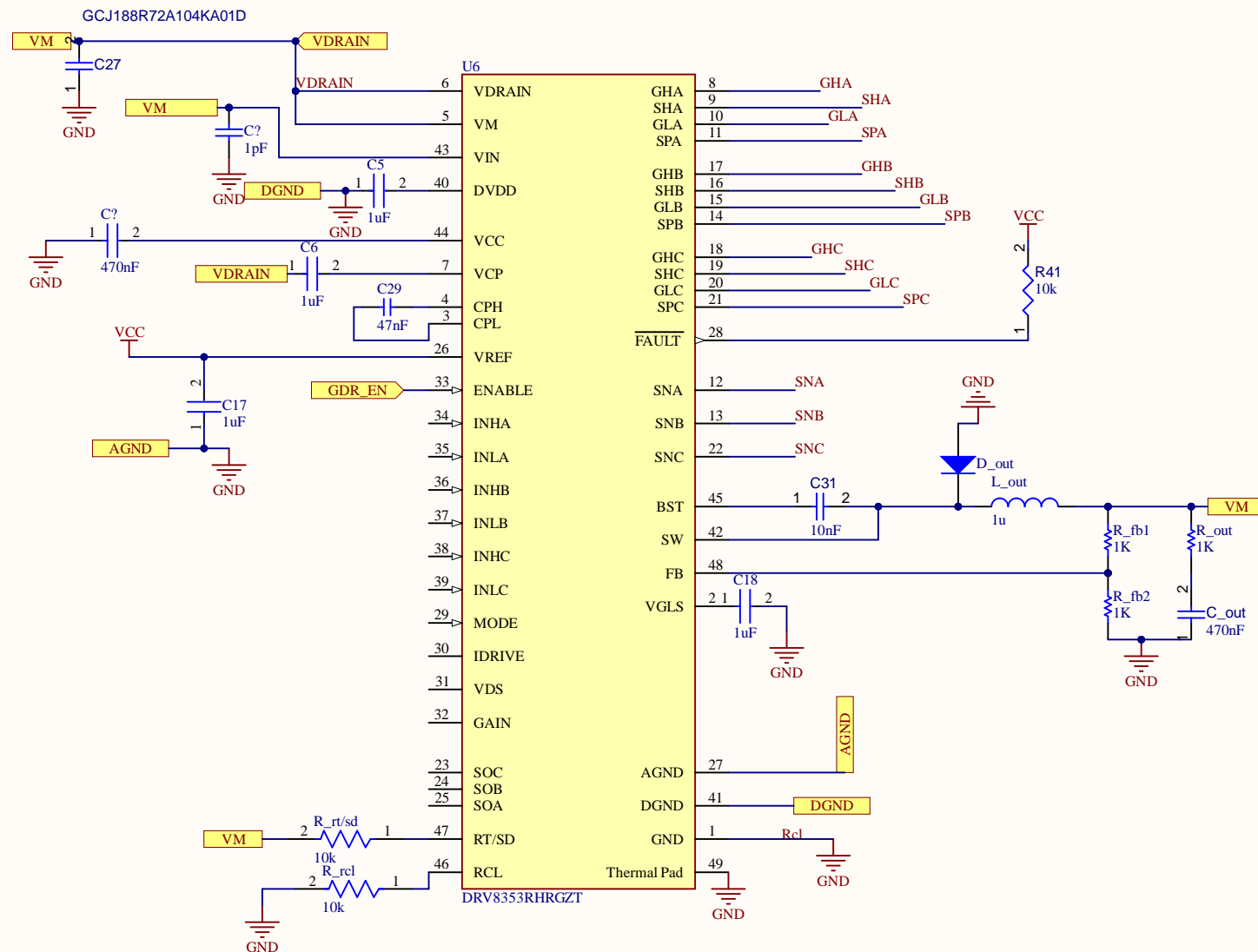
For this design example, use Equation 6 to calculate the value of C2.

$$2 \times 10 \text{ kHz} < \frac{1}{2\pi \times R1 \times C2} \tag{6}$$

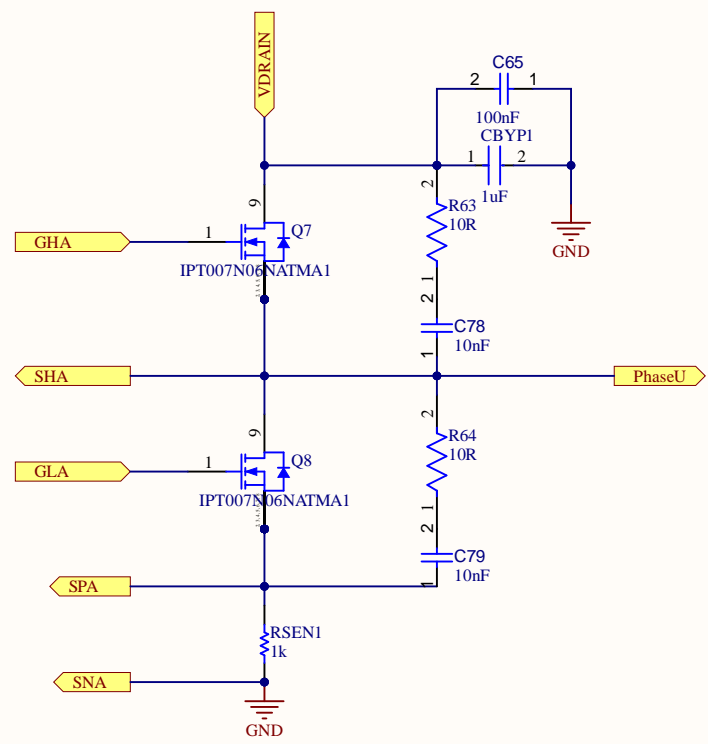
An R1 value of 10 kΩ and a C2 value less than 820 pF satisfy the requirement for a 10-kHz system bandwidth. A selection of R1 = 10 kΩ and C2 = 680 pF can cause a low-pass filter with a corner frequency of 23.4 kHz.

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In this application, the DRV8353R is configured to use one sense amplifier in unidirectional mode for a summing current sense scheme often used in trapezoidal or hall-based BLDC commutation control. Additionally, the device is configured in dual supply mode using the integrated buck regulator for the VM gate drive voltage supply to decrease internal power dissipation.

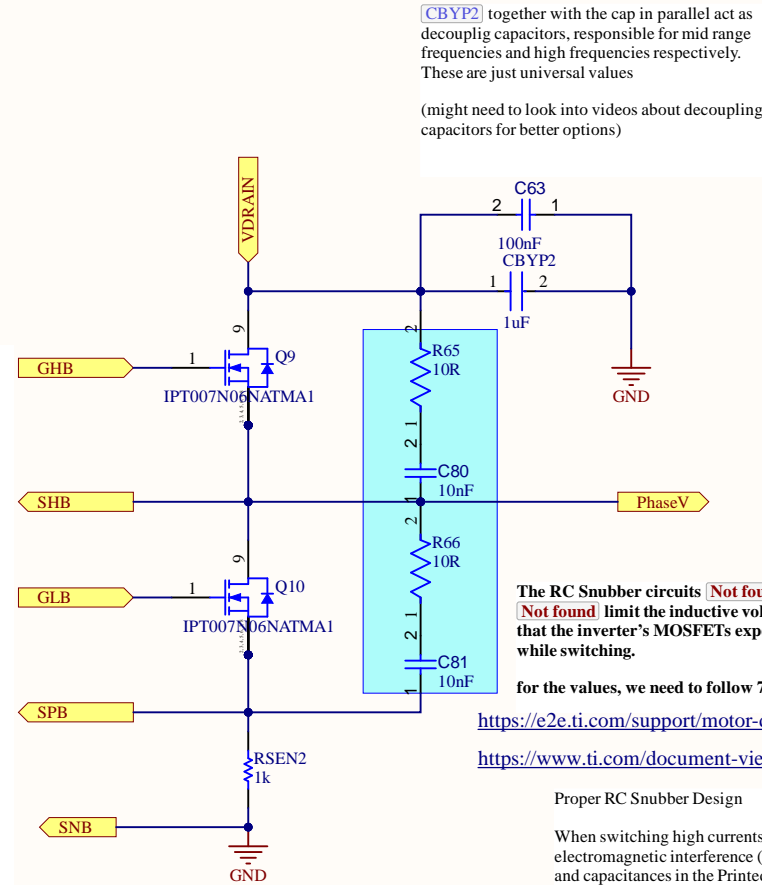
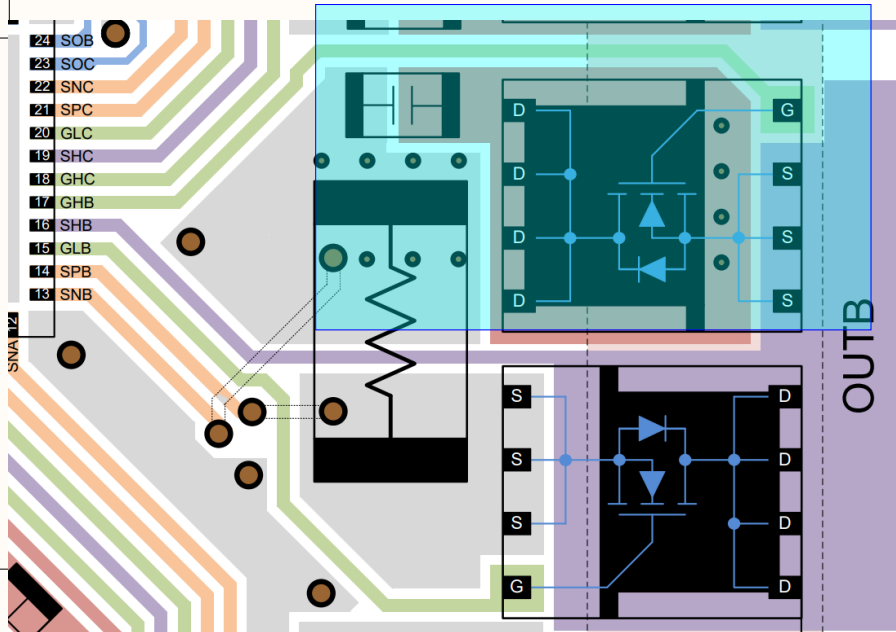


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The other big chunk is the shunt resistor **RSEN2**, with its value requiring a double check, which doesn't seem to have a cap in parallel

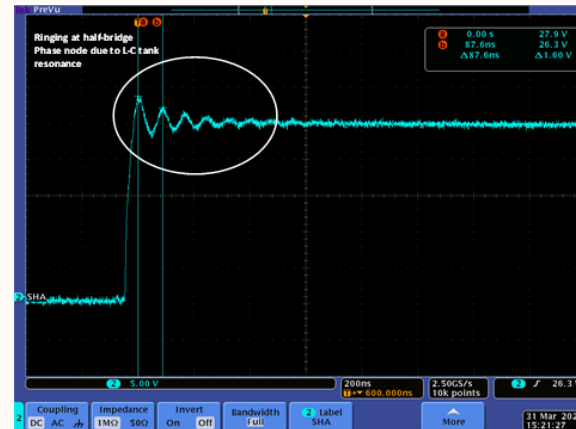


for the values, we need to follow 7-step

<https://www.ti.com/document-viewer/lit/html/SSZTBC7>

Proper RC Snubber Design

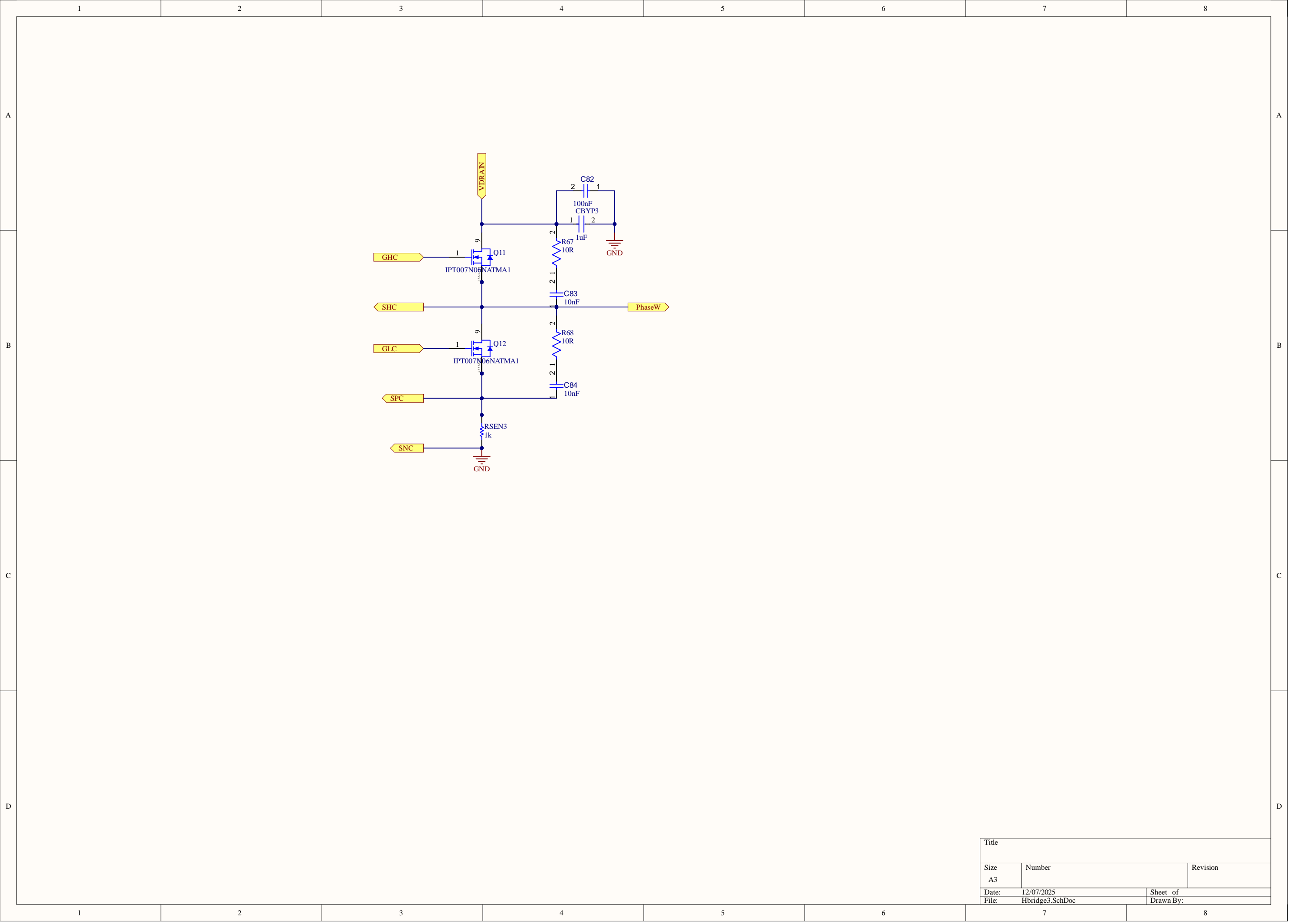
When switching high currents through external power MOSFETs to commutate a BLDC motor, ringing can occur, leading to concerns in electromagnetic interference (EMI), circuit jitter, excessive power dissipation, and overstressing components. This is often due to parasitic inductances and capacitances in the Printed Circuit Board (PCB), specifically in the high-current-carrying phase nets between the high-side and low-side MOSFETs. Inductors and capacitors form an inductor-capacitor (L-C) tank circuit, resulting in resonance during switching events.



To calculate the resistor (R_{snub}) and capacitor (C_{snub}) values of the R-C snubber circuit, we will use a 7-step procedure that shifts the resonant frequency of the MOSFET ringing to calculate the circuit's parasitic capacitance (C_0) and inductance (L). Once those are known, they will be used to derive the values of the R-C snubber. The example shown uses the RC snubber next to the CSD18540Q5B MOSFETs ($Q_{gd} = 6.8nC$) of the DRV8343-Q1 EVM.

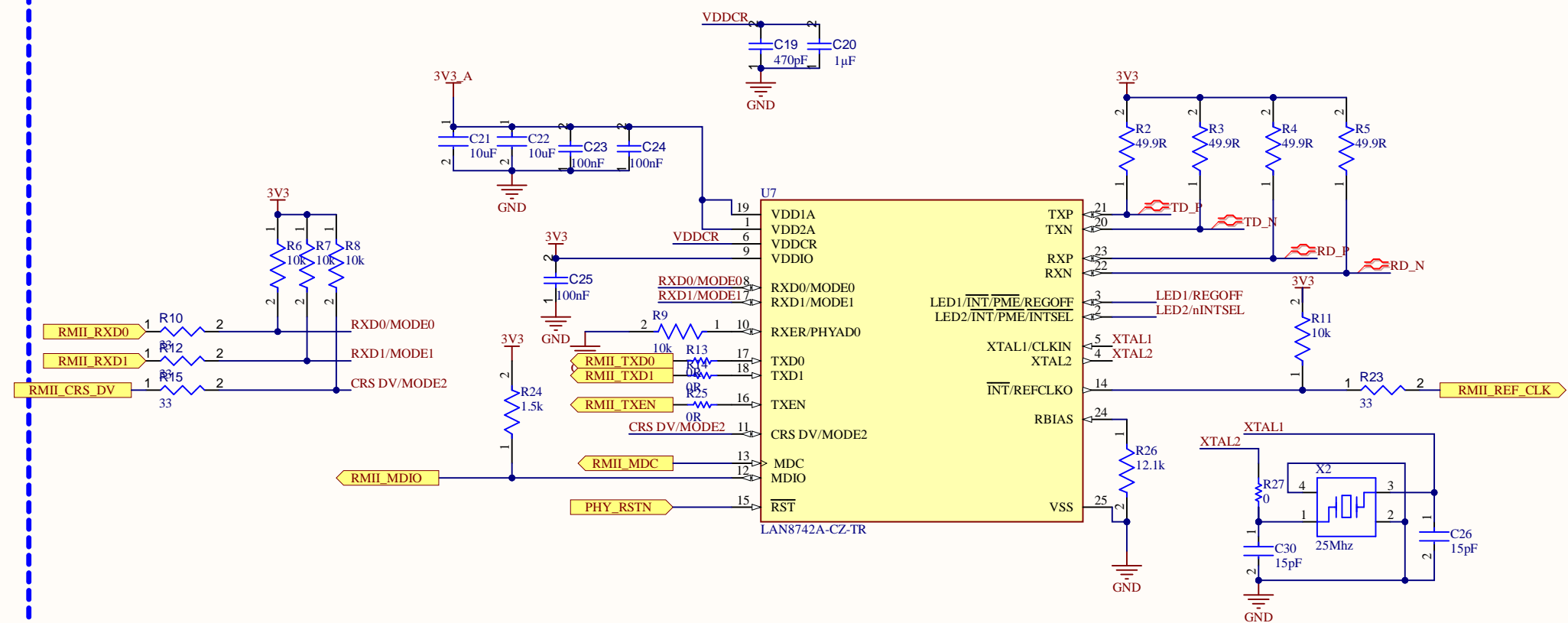
Seven steps to calculate R-C Snubber (with Example)		
Steps	Description	Example
Step 1	Measure the oscillation frequency (f_0) of the V_{DS} ringing with no RC snubber. See Figure 3.	$f_0 = \frac{1}{82ns} = 12.2\text{ MHz}$
Step 2	Add a capacitor (C_1) in parallel with the rectifier or FET and measure the shifted oscillation frequency (f_1). Select a C_1 value that is several times larger than the rectifier's stated typical capacitance at full-reverse voltage in the datasheet. In this example, the rectifier's capacitance is 22pF, so I chose a 100pF value for C_1 . A frequency shift of at least 50% is reasonable. See Figure 4.	$C_1 = 100pF$ $f_1 = \frac{1}{90ns} = 11.1\text{ MHz}$
Step 3	Calculate the frequency shift ratio: $m = \frac{f_0}{f_1}$	$m = \frac{12.2\text{ MHz}}{11.1\text{ MHz}} = 1.1$

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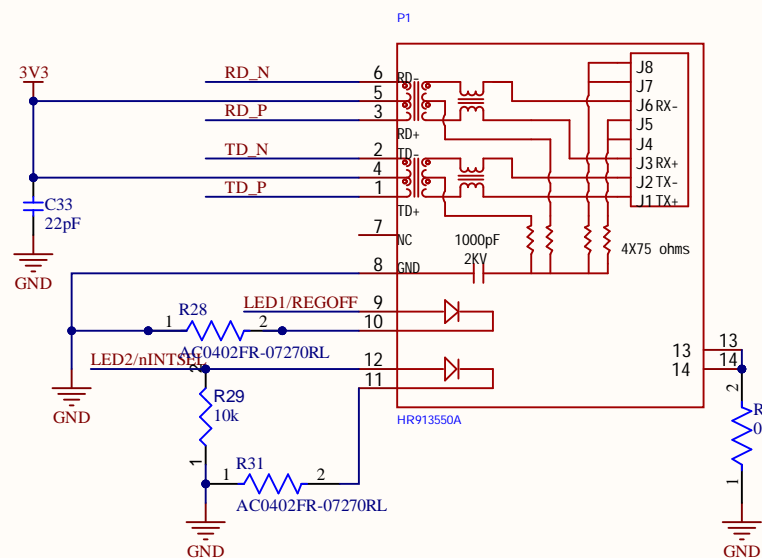


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ETHERNET-PHY

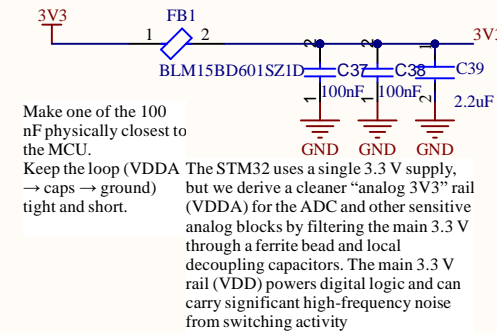


RJ45 MAG-JACK (RX/TX)

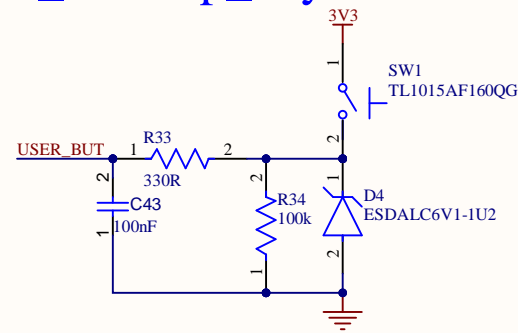


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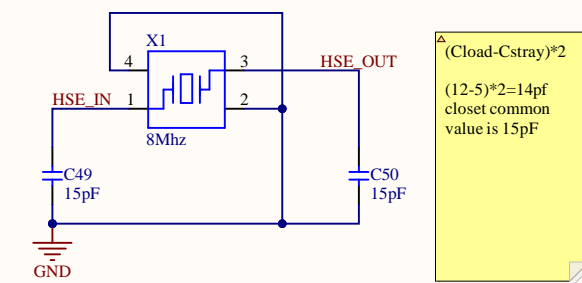
Analogue Clean



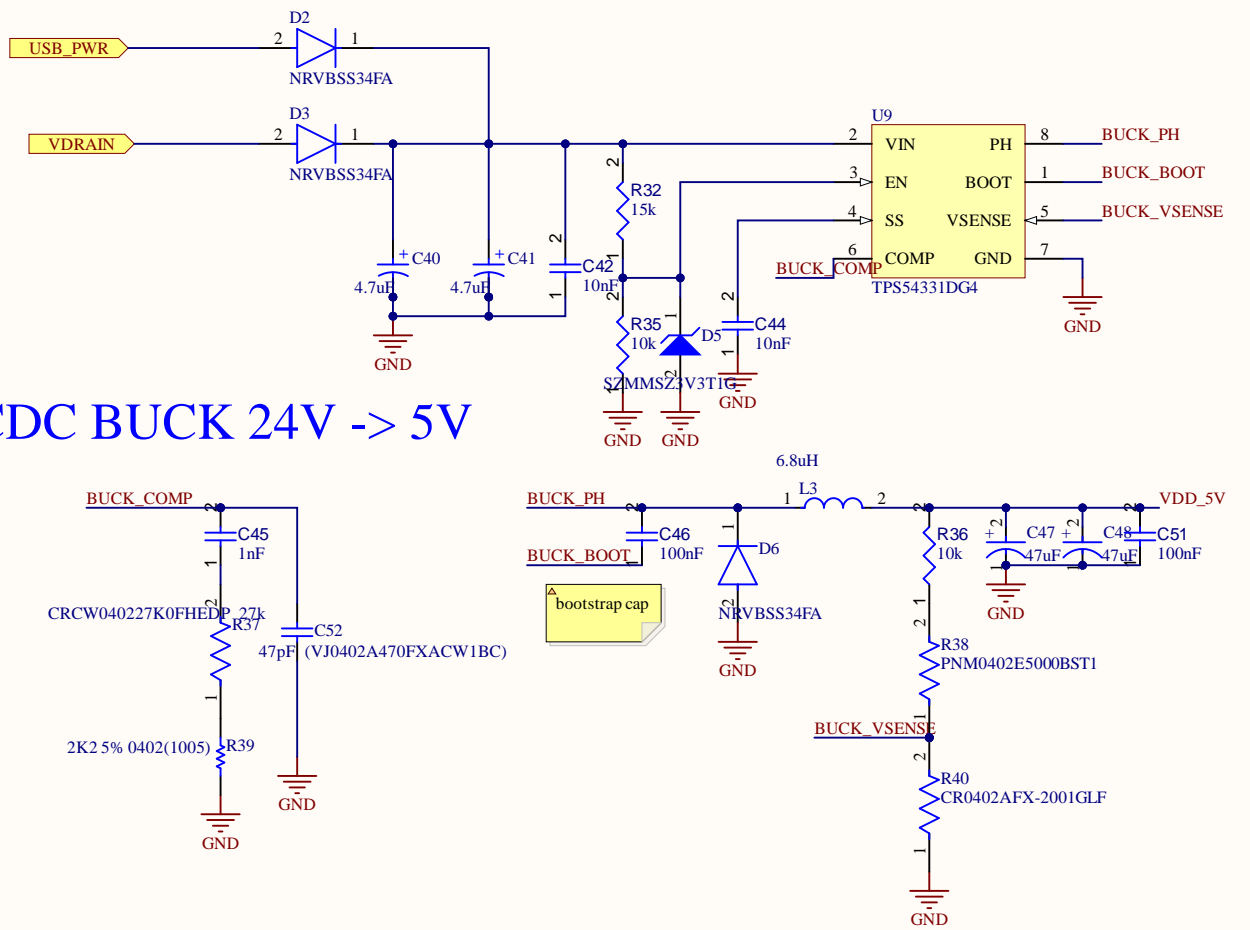
User_wakeup_key



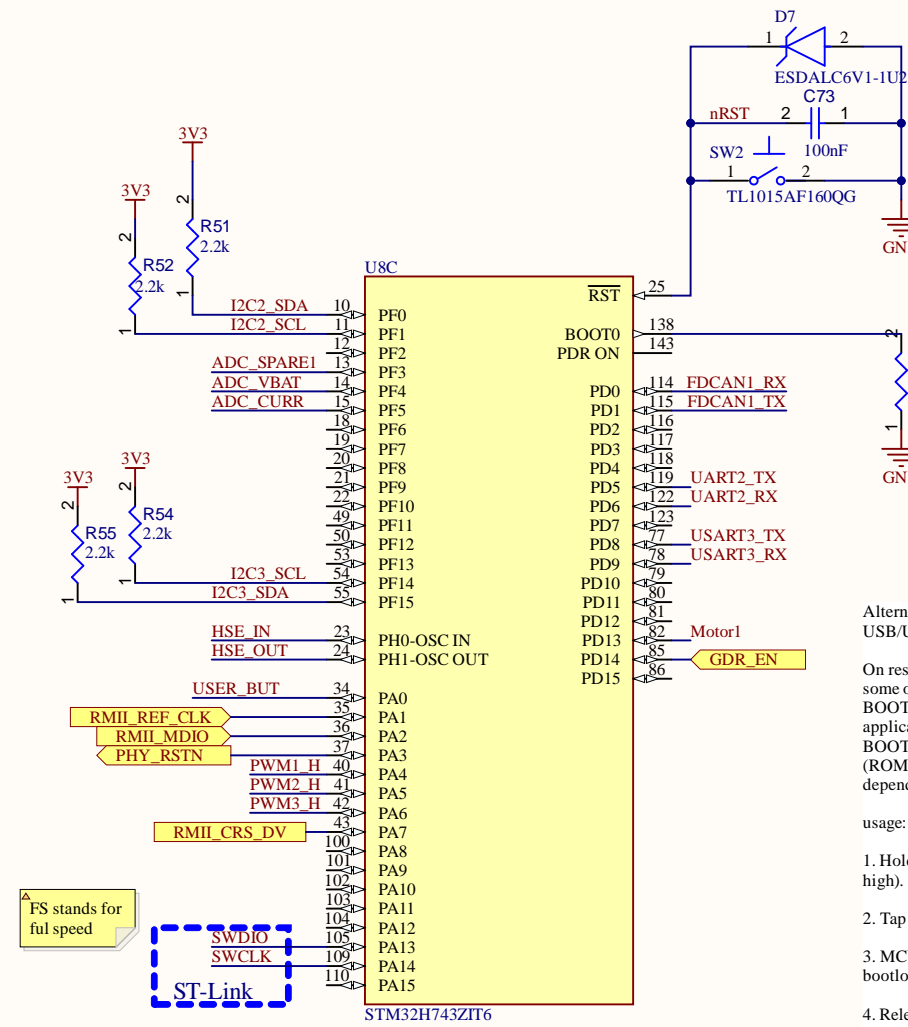
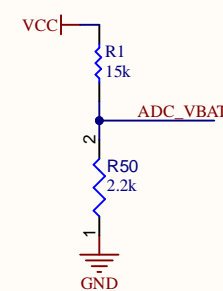
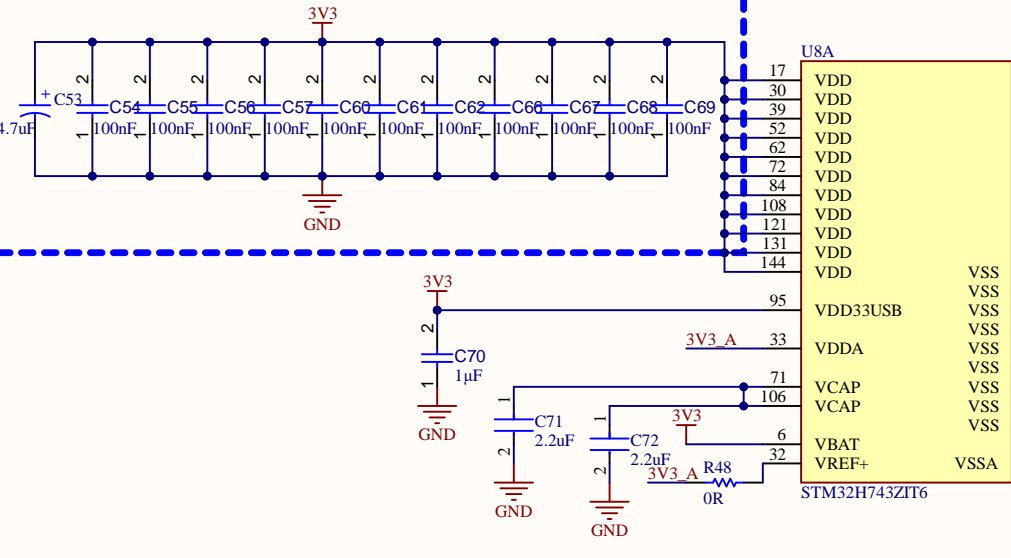
XTAL Oscillator



DCDC BUCK 24V -> 5V



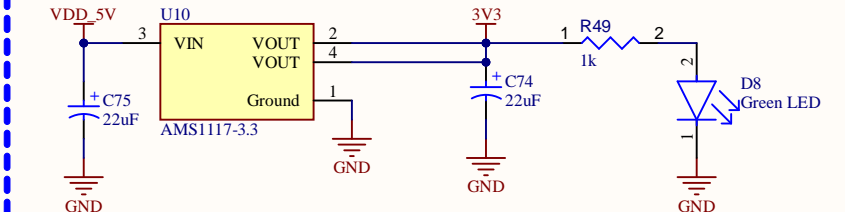
Input Bypass



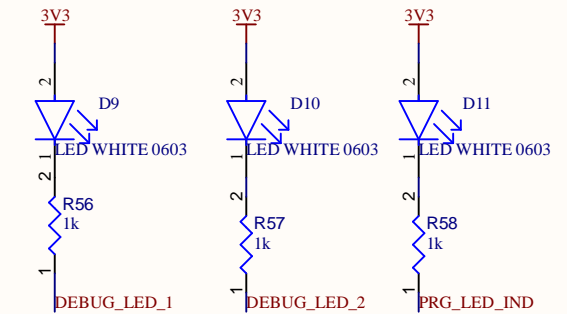
Alternatively, If we want a "field update via USB/UART" story with no ST-LINK, On reset, the MCU samples BOOT0 (and some option bits) to decide boot mode: BOOT0 = 0 → boot from main flash (normal application). BOOT0 = 1 → boot from "system memory" (ROM bootloader) or other memories depending on options.

- usage:
1. Hold the BOOT button (BOOT0 pulled high).
 2. Tap RESET (or power cycle).
 3. MCU samples BOOT0 = 1 → enters ROM bootloader.
 4. Release BOOT; next reset will boot from flash again.

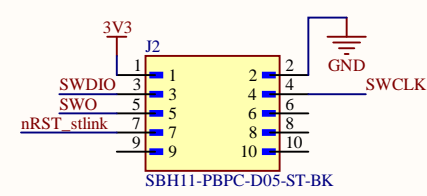
LDO 5V->3V3



Debug Leds



ST-Link JTAG

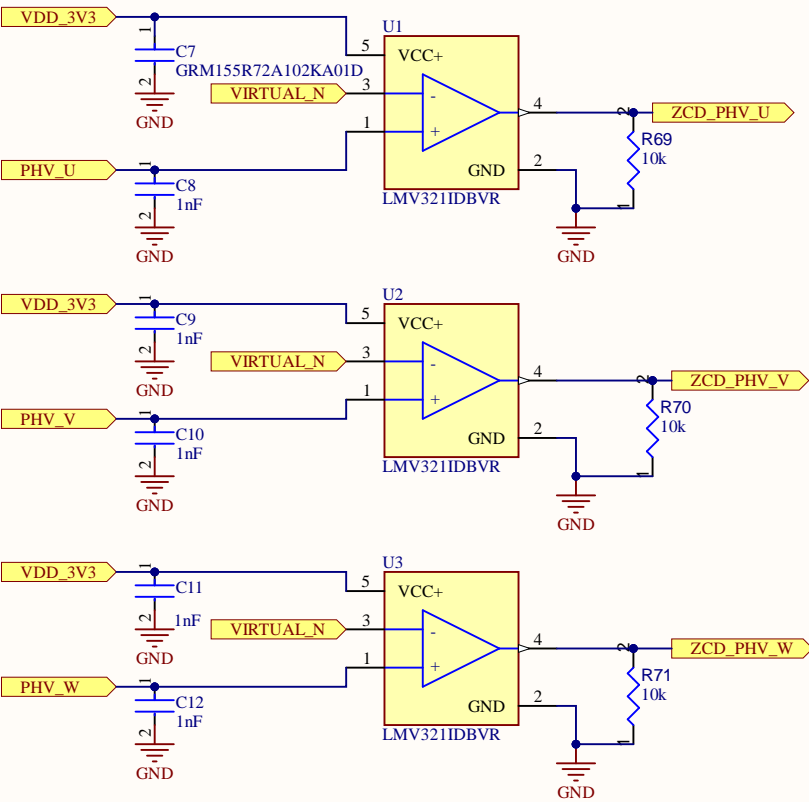


We don't need a usb as we are using a stlink we can, but that requires a on board second stm32 that serves as a stlink chip separately, which is extra work to incorporate

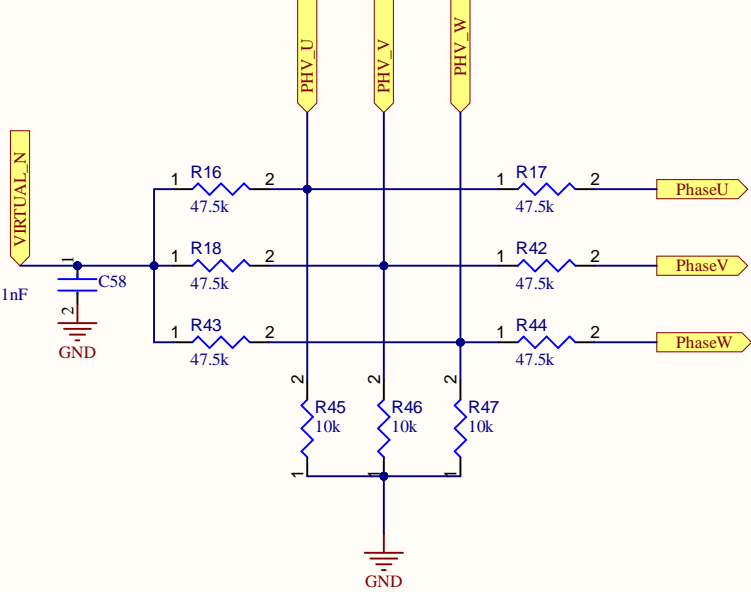
USB-typeC maybe? just for power but We have to consid

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ZCD (3x Zero-Crossing Detectors)



BEMF (Phase Voltage) Measurement



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